Annex F
Photographs of Defect Types Used in the Test Bed

This annex provides photographs of all defect types used in the test bed. Both naturally occurring and fabricated defects are shown.

Chaffed Defects (DT-1)

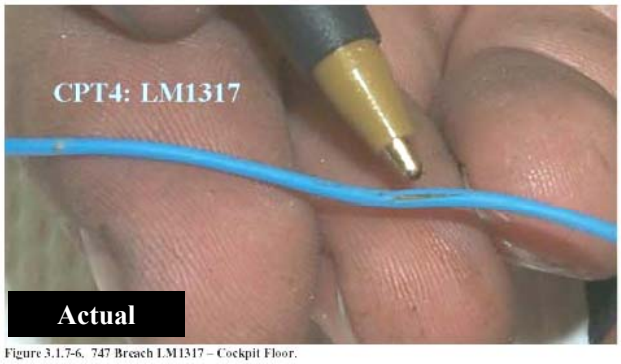
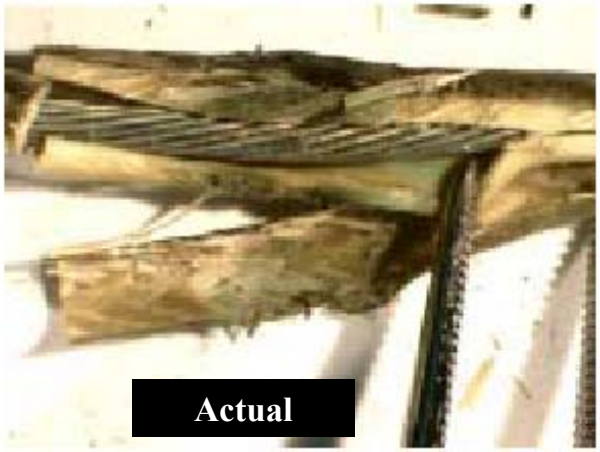
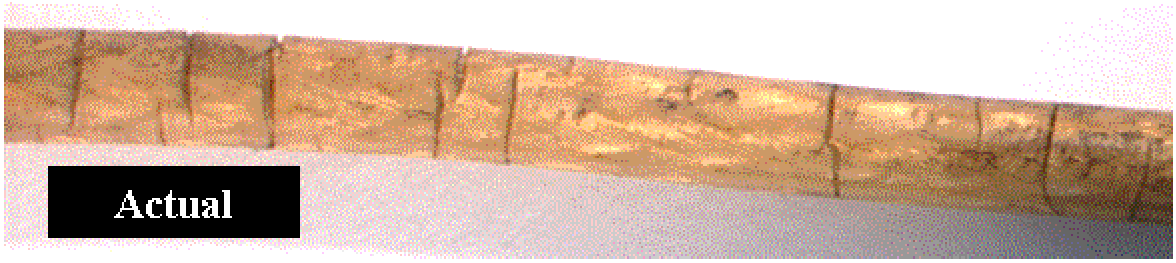


Figure 3.1.7-6. 747 Breach LM1317 – Cockpit Floor.

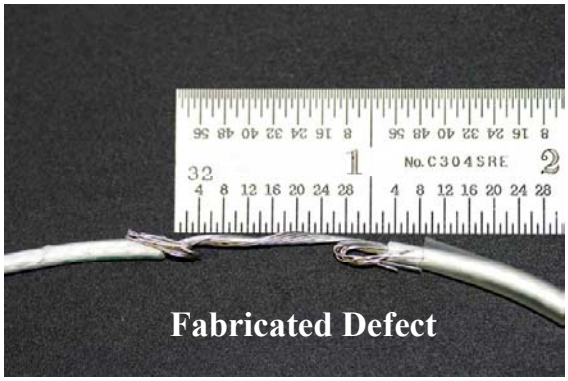
Breach Defects (DT-2)



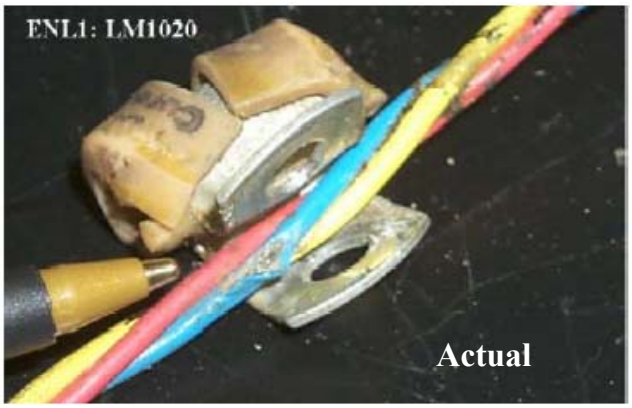
Cracked Defects (DT-3)



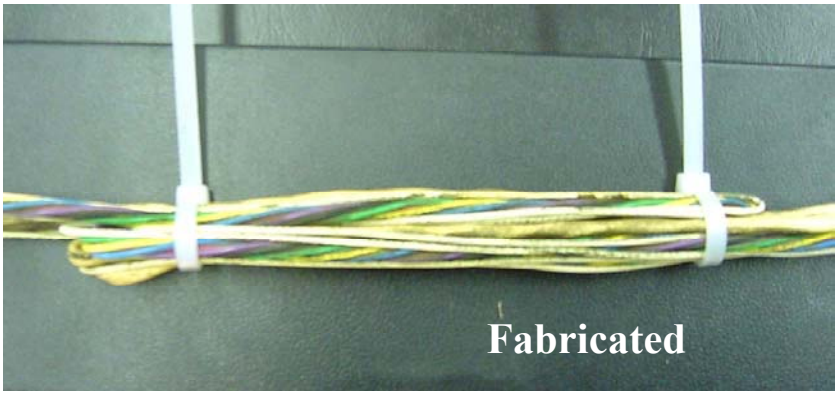
Conductor Strand Break Defects (DT-4)



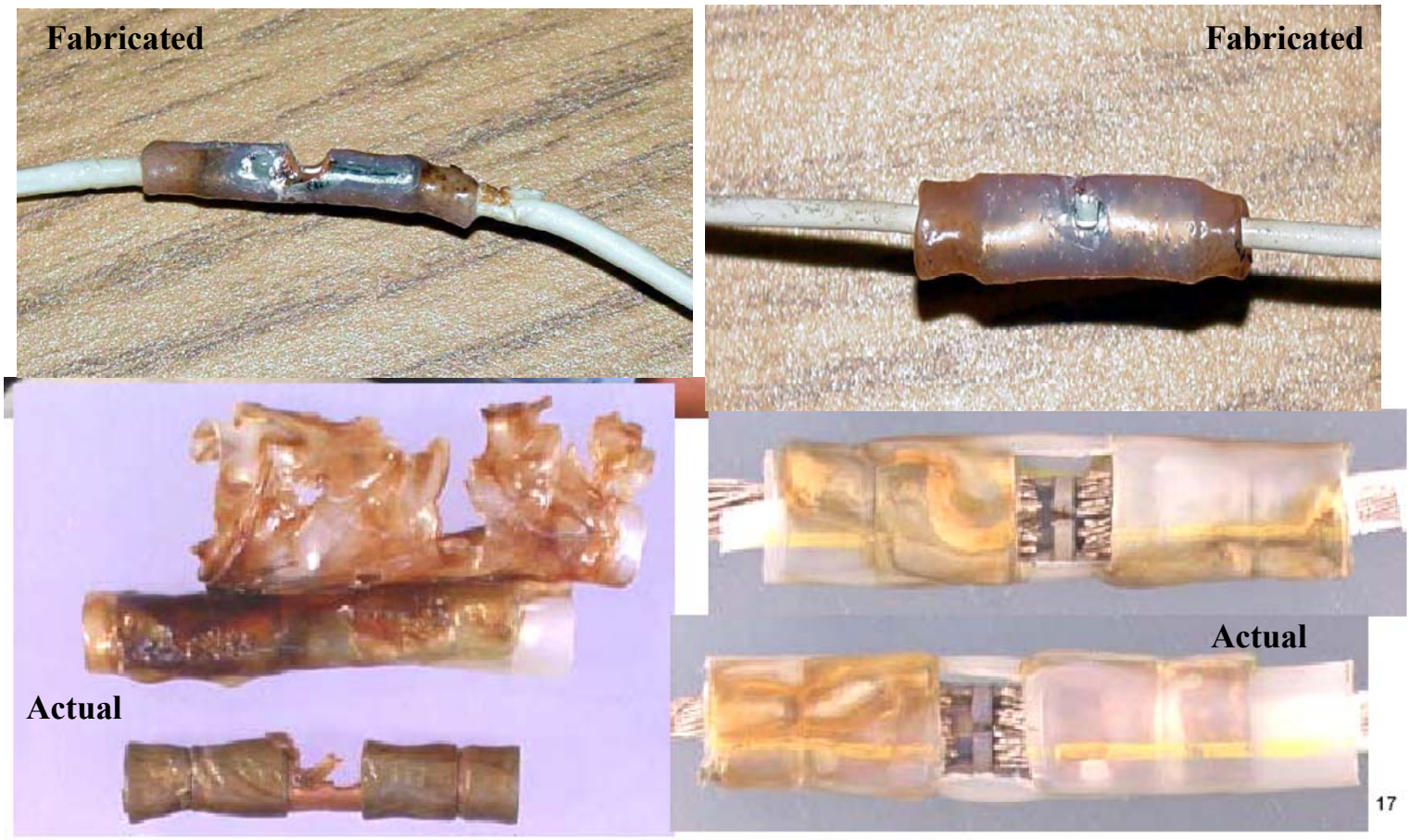
Over-Pressured Clamps Defects (DT-5)



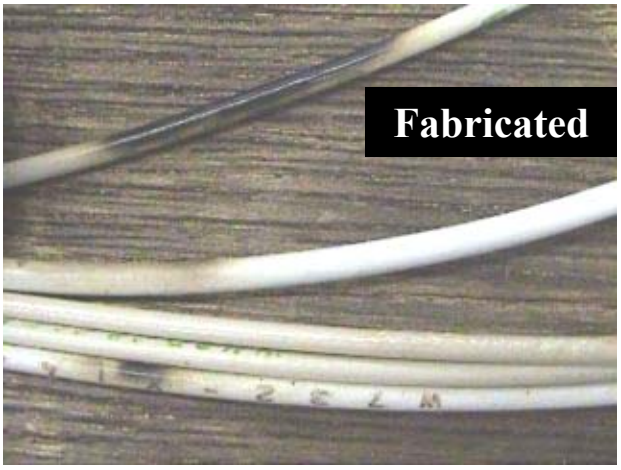
Excessive Bend Radius Defects (DT-6)

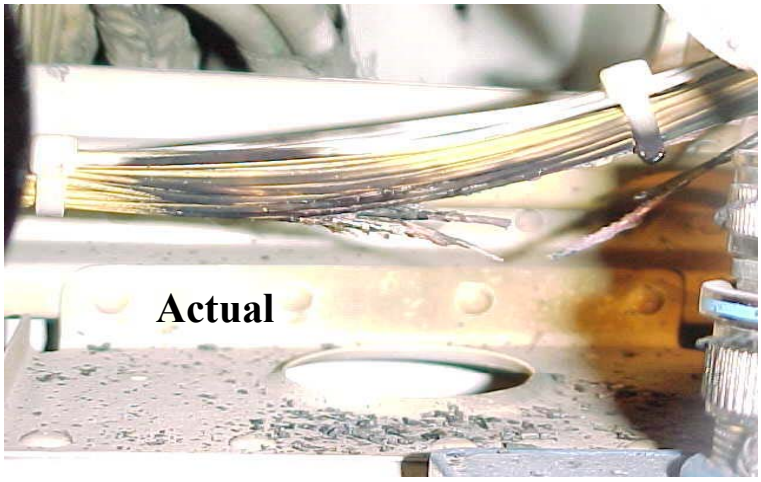


Faulted Splice Defects (DT-7)

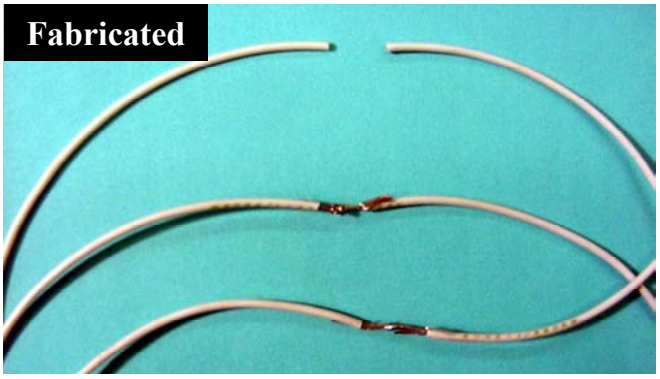


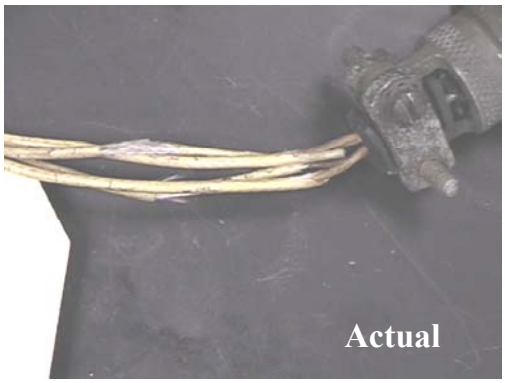
Charred Insulation Defects (DT-8)



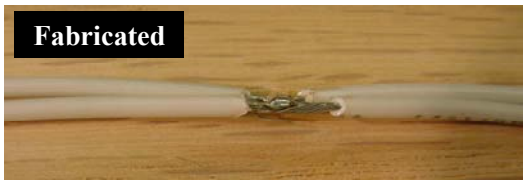


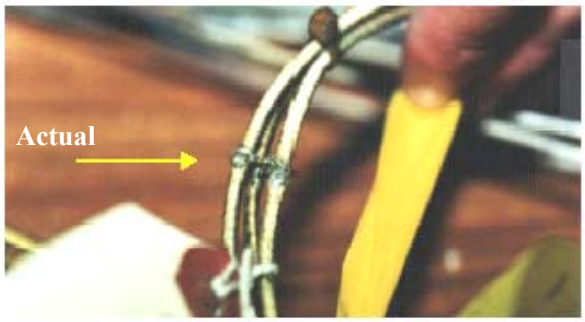
Conductor Opened Defects (DT-9)





Conductor Shorted Defects (DT-10)





Actual